TOSHIBA GT15Q311

#### TOSHIBA INSULATED GATE BIPOLAR TRANSISTOR SILICON N CHANNEL IGBT

# G T 1 5 Q 3 1 1

#### HIGH POWER SWITCHING APPLICATIONS

#### MOTOR CONTROL APPLICATIONS

The 3rd Generation

Enhancement-Mode

High Speed :  $t_f = 0.32 \,\mu s$  (Max.)

Low Saturation Voltage :  $V_{CE (sat)} = 2.7 \text{ V (Max.)}$ 

FRD included between Emitter and Collector

### MAXIMUM RATINGS (Ta = 25°C)

| CHARACTERIS                             | SYMBOL             | RATING            | UNIT                 |   |  |
|---|--------------------|-------------------|----------------------|---|--|
| Collector-Emitter Voltag                | $v_{CES}$          | 1200              | V                    |   |  |
| Gate-Emitter Voltage                    | $v_{GES}$          | ±20               | V                    |   |  |
| Collector Current                       | DC                 | $I_{\mathbf{C}}$  | 15                   | A |  |
| Conector Current                        | 1ms                | $I_{CP}$          | 30                   | A |  |
| Emitter-Collector                       | DC                 | $I_{\mathbf{F}}$  | 15                   | Α |  |
| Forward Current                         | 1ms                | $I_{\mathbf{FM}}$ | 30                   | A |  |
| Collector Power Dissipation (Tc = 25°C) |                    | $P_{\mathbf{C}}$  | 160                  | w |  |
| Junction Temperature                    | $T_{ m j}$         | 150               | °C                   |   |  |
| Storage Temperature Ra                  | $\mathrm{T_{stg}}$ | -55~150           | $^{\circ}\mathrm{C}$ |   |  |

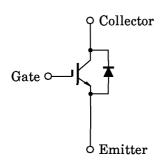
# 15.9MAX 15.3MAX GATE COLLECTOR (HEAT SINK)

Unit in mm

**JEDEC EIAJ TOSHIBA** 2-16H1A

Weight: 3.65 g

## **EOUIVALENT CIRCUIT**



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ELECTRICAL CHARACTERISTICS (Ta = 25°C)

| CHARAC                               | TERISTIC        | SYMBOL                | TEST CONDITION   | MIN. | TYP. | MAX. | UNIT    |
|--------------------------------------|-----------------|-----------------------|--|------|------|------|---------|
| Gate Leakage Current                 |                 | $I_{	ext{GES}}$       | $V_{GE} = \pm 20 V, V_{CE} = 0$                                | _    | _    | ±500 | nA      |
| Collector Cut-C                      | Off Current     | ICES                  | $V_{CE} = 1200 \text{ V}, V_{GE} = 0$                          | _    | _    | 1.0  | mA      |
| Gate-Emitter (                       | Cut-Off Voltage | V <sub>GE</sub> (OFF) | $I_{C} = 1.5 \text{ mA}, V_{CE} = 5 \text{ V}$                 | 4.0  | _    | 7.0  | V       |
| Collector-Emitt<br>Voltage           | ter Saturation  | V <sub>CE</sub> (sat) | $I_{C} = 15 \text{ A}, \text{ V}_{GE} = 15 \text{ V}$          | _    | 2.1  | 2.7  | V       |
| Input Capacitance                    |                 | Cies                  | $V_{CE} = 50 \text{ V}, V_{GE} = 0, f = 1 \text{ MHz}$         | _    | 950  | _    | рF      |
|                                      | Rise Time       | t <sub>r</sub>        | Inductive Load   | _    | 0.05 | _    |         |
| Switching                            | Turn-On Time    | ton                   | $V_{CC} = 600 \text{ V}, I_{C} = 15 \text{ A}$                 | _    | 0.12 | _    |         |
| Time                                 | Fall Time       | tf                    | $V_{GG} = \pm 15 V, R_G = 56 \Omega$                           | _    | 0.16 | 0.40 | $\mu$ s |
|                                      | Turn-Off Time   | $t_{ m off}$          | (Note)   | _    | 0.56 | _    |         |
| Peak Forward                         | Voltage         | $V_{\mathbf{F}}$      | $I_{F} = 15 \text{ A}, V_{GE} = 0$                             | _    | _    | 3.0  | V       |
| Reverse Recovery Time t <sub>1</sub> |                 | t <sub>rr</sub>       | $I_{\rm F} = 15  {\rm A, \ di / dt} = -200  {\rm A / \ \mu s}$ | _    | _    | 350  | ns      |
| Thermal Resistance (IGBT)            |                 | R <sub>th (j-c)</sub> | _  | _    | _    | 0.78 | °C/W    |
| Thermal Resistance (Diode)           |                 | $ m R_{th(j-c)}$      | _  |      | _    | 1.60 | °C/W    |

(Note): Switching time measurement circuit and input/output waveforms

